

Notice of References Cited

Application/Control No.

10/081,730

Applicant(s)/Patent Under

Reexamination

LIM ET AL.

Examiner

Hiep Nguyen

Art Unit

2816

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,323,735	11-2001	Welland et al.	331/36L
	B	US-			
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	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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